S	eard	arch Notes		

Application/Control No.	Applicant(s)/Patent unde Reexamination	er
10/810,121	LIU ET AL.	
Examiner	Art Unit	
Janet M. Wilkens	3637	

SEARCHED			
Class	Subclass	Date	Examiner
312	243.2 a33.1	6/6/06	dwn
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Eistsurchis	e1818P	dwn
Inventor seach	c18106	dwn